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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	36864
Number of I/O	68
Number of Gates	250000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TJ)
Package / Case	100-TQFP
Supplier Device Package	100-VQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a3p250-1vqg100m

Military ProASIC3/EL Ordering Information

A3P1000 – 1 FG G 144 Y M

- **Part Number**
  - **Military ProASIC3/EL Devices**
    - A3P250 = 250,000 System Gates
    - A3PE600L = 600,000 System Gates
    - A3P1000 = 1,000,000 System Gates
    - A3PE3000L = 3,000,000 System Gates
  - **Military ProASIC3/EL Devices with ARM Cortex-M1**
    - M1A3P1000 = 1,000,000 System Gates
    - M1A3PE3000L = 3,000,000 System Gates
- **Speed Grade**
  - Blank = Standard
  - 1 = 15% Faster than Standard
  - 2 = 25% Faster than Standard
  - Note: Speed Grade –2 is available only for A3P1000 device in FG256 and FG484 packages
- **Package Type**
  - VQ = Very Thin Quad Flat Pack (0.5 mm pitch)
  - FG = Fine Pitch Ball Grid Array (1.0 mm pitch)
  - PQ = Plastic Quad Flat Pack (0.5 mm pitch)
- **Lead-Free Packaging**
  - Blank = Standard Packaging
  - G = RoHS-Compliant (Green) Packaging
- **Package Lead Count**
- **Security Feature**
  - Y = Device Includes License to Implement IP Based on the Cryptography Research, Inc. (CRI) Patent Portfolio
- **Application (Temperature Range)**
  - M = Military (–55°C to 125°C Junction Temperature)

LICENSED DPA COUNTERMEASURES

Temperature Grade Offerings

Package	A3P250	A3PE600L	A3P1000	A3PE3000L
ARM Cortex-M1 Devices			**M1A3P1000**	**M1A3PE3000L**
VQ100	M	–	–	–
PQ208	–	–	M	–
FG144	–	–	M	–
FG256	–	–	M	–
FG484	–	M	M	M
FG896	–	–	–	M

Note: M = Military temperature range: –55°C to 125°C junction temperature

Table 2-15 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings Applicable to Advanced I/O Banks for A3P250 and A3P1000 Only

	VMV (V)	Static Power PDC6 (mW)[1]	Dynamic Power PAC9 (µW/MHz)[2]
Single-Ended			
3.3 V LVTTL / 3.3 V LVCMOS	3.3	–	16.22
3.3 V LVCMOS – Wide Range	3.3	–	16.22
2.5 V LVCMOS	2.5	–	4.65
1.8 V LVCMOS	1.8	–	1.65
1.5 V LVCMOS (JESD8-11)	1.5	–	0.98
3.3 V PCI	3.3	–	17.64
3.3 V PCI-X	3.3	–	17.64
Differential			
LVDS	2.5	2.26	0.83
LVPECL	3.3	5.72	1.81

Notes:

1. *PDC6 is the static power (where applicable) measured on VMV.*
2. *PAC9 is the total dynamic power measured on VMV.*

Table 2-16 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings Applicable to Standard Plus I/O Banks for A3P250 and A3P1000 Only

	VMV (V)	Static Power PDC6 (mW) [1]	Dynamic Power PAC9 (µW/MHz) [2]
Single-Ended			
3.3 V LVTTL / 3.3 V LVCMOS	3.3	–	16.23
3.3 V LVCMOS – Wide Range	3.3	–	16.23
2.5 V LVCMOS	2.5	–	4.66
1.8 V LVCMOS	1.8	–	1.64
1.5 V LVCMOS (JESD8-11)	1.5	–	0.99
3.3 V PCI	3.3	–	17.64
3.3 V PCI-X	3.3	–	17.64

Notes:

1. *PDC6 is the static power (where applicable) measured on VMV.*
2. *PAC9 is the total dynamic power measured on VMV.*

Power Consumption of Various Internal Resources

Table 2-20 • **Different Components Contributing to Dynamic Power Consumption in Military ProASIC3/EL Devices Operating at 1.2 V VCC**

Parameter	Definition	Device-Specific Dynamic Power (µW/MHz)	
		A3PE3000L	A3PE600L
PAC1	Clock contribution of a Global Rib	8.34	3.99
PAC2	Clock contribution of a Global Spine	4.28	2.22
PAC3	Clock contribution of a VersaTile row	0.94	0.94
PAC4	Clock contribution of a VersaTile used as a sequential module	0.08	0.08
PAC5	First contribution of a VersaTile used as a sequential module	0.05	
PAC6	Second contribution of a VersaTile used as a sequential module	0.19	
PAC7	Contribution of a VersaTile used as a combinatorial module	0.11	
PAC8	Average contribution of a routing net	0.45	
PAC9	Contribution of an I/O input pin (standard-dependent)	See Table 2-14 on page 2-9 through Table 2-16 on page 2-10.	
PAC10	Contribution of an I/O output pin (standard-dependent)	See Table 2-17 on page 2-11 through Table 2-19 on page 2-12.	
PAC11	Average contribution of a RAM block during a read operation	25.00	
PAC12	Average contribution of a RAM block during a write operation	30.00	
PAC13	Dynamic contribution for PLL	1.74	

1.5 V Core Voltage

Table 2-32 • Summary of I/O Timing Characteristics—Software Default Settings –1 Speed Grade, Military-Case Conditions: T_J = 125°C, VCC = 1.425 V, Worst Case VCCI Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Standard	Drive Strength (mA)	Equivalent Software Default Drive Strength Option[1]	Slew Rate	Capacitive Load (pF)[2]	External Resistor (Ω)	t_{DOUT} (ns)	t_{DP} (ns)	t_{DIN} (ns)	t_{PY} (ns)	t_{PYS} (ns)	t_{EOUT} (ns)	t_{ZL} (ns)	t_{ZH} (ns)	t_{LZ} (ns)	t_{HZ} (ns)	t_{ZLS} (ns)	t_{ZHS} (ns)
3.3 V LVTTL / 3.3 V LVCMOS	12 mA	12 mA	High	5	–	0.52	1.97	0.03	1.23	1.78	0.34	1.99	1.46	2.63	2.89	3.23	2.71
3.3 V LVCOMS Wide Range[3]	100 µA	12 mA	High	5	–	0.52	2.89	0.03	1.61	2.44	0.34	2.88	2.12	3.89	4.25	4.12	3.36
2.5 V LVCMOS	12 mA	12 mA	High	5	–	0.52	2.01	0.03	1.49	1.93	0.34	2.02	1.65	2.71	2.78	3.27	2.89
1.8 V LVCMOS	12 mA	12 mA	High	5	–	0.52	2.24	0.03	1.44	2.14	0.34	2.26	1.84	3.02	3.41	3.51	3.08
1.5 V LVCMOS	12 mA	12 mA	High	5	–	0.52	2.60	0.03	1.60	2.35	0.34	2.62	2.14	3.21	3.52	3.87	3.39
3.3 V PCI	Per PCI spec	–	High	10	25[4]	0.52	2.25	0.03	2.03	2.88	0.34	2.27	1.58	2.64	2.89	3.52	2.83
3.3 V PCI-X	Per PCI-X spec	–	High	10	25[4]	0.52	2.25	0.03	2.03	2.88	0.34	2.27	1.58	2.64	2.89	3.52	2.83
3.3 V GTL	20 mA[5]	20 mA[5]	High	10	25	0.52	1.68	0.03	1.79	–	0.34	1.58	1.68	–	–	2.83	2.92
2.5 V GTL	20 mA[5]	20 mA[5]	High	10	25	0.52	1.72	0.03	1.73	–	0.34	1.69	1.72	–	–	2.93	2.97
3.3 V GTL+	35 mA	35 mA	High	10	25	0.52	1.66	0.03	1.79	–	0.34	1.63	1.66	–	–	2.88	2.90
2.5 V GTL+	33 mA	33 mA	High	10	25	0.52	1.75	0.03	1.73	–	0.34	1.76	1.69	–	–	3.00	2.94
HSTL (I)	8 mA	8 mA	High	20	25	0.52	2.57	0.03	2.14	–	0.34	2.59	2.55	–	–	3.84	3.79
HSTL (II)	15 mA[5]	15 mA[5]	High	20	50	0.52	2.44	0.03	2.14	–	0.34	2.46	2.19	–	–	3.71	3.43
SSTL2 (I)	15 mA	15 mA	High	30	25	0.52	1.68	0.03	1.58	–	034	1.69	1.46	–	–	1.69	1.46
SSTL2 (II)	18 mA	18 mA	High	30	50	0.52	1.72	0.03	1.58	–	0.34	1.73	1.39	–	–	1.73	1.39
SSTL3 (I)	14 mA	14 mA	High	30	25	0.52	1.83	0.03	1.51	–	0.34	1.84	1.45	–	–	1.84	1.45
SSTL3 (II)	21 mA	21 mA	High	30	50	0.52	1.63	0.03	1.51	–	0.34	1.64	1.31	–	–	1.64	1.31
LVDS	24 mA	–	High	–	–	0.52	1.48	0.03	1.86	–	–	–	–	–	–	–	–
LVPECL	24 mA	–	High	–	–	0.52	1.40	0.03	1.61	–	–	–	–	–	–	–	–

Notes:

1. *Note that 3.3 V LVCMOS wide range is applicable to 100 µA drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges only.*
2. *Output delays provided in this table were extracted with an output load indicated in the Capacitive Load column. For a specific output load, refer to Designer software.*
3. *All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD8-B specification.*
4. *Resistance is used to measure I/O propagation delays as defined in PCI specifications. See Figure 2-14 on page 2-71 for connectivity. This resistor is not required during normal operation.*
5. *Output drive strength is below JEDEC specification.*
6. *For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.*

Table 2-41 • I/O Short Currents IOSH/IOSL
Applicable to Advanced I/O Banks for A3P250 and A3P1000 Only

	Drive Strength	I_{OSL} (mA)*	I_{OSH} (mA)*
3.3 V LVTTL / 3.3V LVCMOS	2 mA	25	27
	4 mA	25	27
	6 mA	51	54
	8 mA	51	54
	12 mA	103	109
	16 mA	132	127
	24 mA	268	181
3.3 V LVCMOS Wide Range	100 µA	Same specification as regular LVCMOS 3.3 V	
2.5 V LVCMOS	2 mA	16	18
	4 mA	16	18
	6 mA	32	37
	8 mA	32	37
	12 mA	65	74
	16 mA	83	87
	24 mA	169	124
1.8 V LVCMOS	2 mA	9	11
	4 mA	17	22
	6 mA	35	44
	8 mA	45	51
	12 mA	91	74
	16 mA	91	74
1.5 V LVCMOS	2 mA	13	16
	4 mA	25	33
	6 mA	32	39
	8 mA	66	55
	12 mA	66	55
3.3 V PCI/PCI-X	Per PCI/PCI-X specification	103	109

*Note: *T_J = 100°C*

For example, at 110°C, the short current condition would have to be sustained for more than three months to cause a reliability concern. The I/O design does not contain any short circuit protection, but such protection would only be needed in extremely prolonged stress conditions.

Table 2-44 • Duration of Short Circuit Event before Failure

Temperature	Time before Failure
–50ºC	> 20 years
–40°C	> 20 years
0°C	> 20 years
25°C	> 20 years
70°C	5 years
85°C	2 years
100°C	6 months
110°C	3 months
125°C	1 month

Table 2-45 • I/O Input Rise Time, Fall Time, and Related I/O Reliability

Input Buffer	Input Rise/Fall Time (min.)	Input Rise/Fall Time (max.)	Reliability
LVTTL/LVCMOS	No requirement	10 ns *	20 years (110°C)
LVDS/B-LVDS/ M-LVDS/LVPECL	No requirement	10 ns *	10 years (100°C)

*Note: *The maximum input rise/fall time is related to the noise induced in the input buffer trace. If the noise is low, the rise time and fall time of input buffers can be increased beyond the maximum value. The longer the rise/fall times, the more susceptible the input signal is to the board noise. Microsemi recommends signal integrity evaluation/characterization of the system to ensure that there is no excessive noise coupling into input signals.*

Table 2-68 • 3.3 V LVCMOS Wide Range Low Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V
Applicable to Standard Plus I/O Banks

Drive Strength	Equiv. Software Default Drive Strength Option[1]	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
100 µA	4 mA	Std.	0.63	8.71	0.05	1.67	0.45	8.71	7.25	3.87	3.76	12.45	10.99	ns
		–1	0.54	7.41	0.04	1.42	0.39	7.41	6.17	3.29	3.19	10.59	9.35	ns
100 µA	6 mA	Std.	0.63	7.17	0.05	1.67	0.45	7.17	6.31	4.39	4.66	10.91	10.04	ns
		–1	0.54	6.10	0.04	1.42	0.39	6.10	5.37	3.73	3.96	9.28	8.54	ns
100 µA	8 mA	Std.	0.63	7.17	0.05	1.67	0.45	7.17	6.31	4.39	4.66	10.91	10.04	ns
		–1	0.54	6.10	0.04	1.42	0.39	6.10	5.37	3.73	3.96	9.28	8.54	ns
100 µA	12 mA	Std.	0.63	6.09	0.05	1.67	0.45	6.09	5.57	4.75	5.24	9.83	9.31	ns
		–1	0.54	5.18	0.04	1.42	0.39	5.18	4.74	4.04	4.46	8.36	7.92	ns
100 µA	16 mA	Std.	0.63	6.09	0.05	1.67	0.45	6.09	5.57	4.75	5.24	9.83	9.31	ns
		–1	0.54	5.18	0.04	1.42	0.39	5.18	4.74	4.04	4.46	8.36	7.92	ns

Notes:

1. *Note that 3.3 V LVCMOS wide range is applicable to 100 µA drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges ONLY.*
2. *For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.*

Table 2-69 • 3.3 V LVCMOS Wide Range High Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.7 V
Applicable to Standard Plus I/O Banks

Drive Strength	Equiv. Software Default Drive Strength Option[1]	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
100 µA	4 mA	Std.	0.63	4.75	0.05	1.67	0.45	4.75	3.73	3.87	3.97	8.48	7.46	ns
		–1	0.54	4.04	0.04	1.42	0.39	4.04	3.17	3.29	3.38	7.21	6.35	ns
100 µA	6 mA	Std.	0.63	3.87	0.05	1.67	0.45	3.87	2.98	4.38	4.89	7.61	6.72	ns
		–1	0.54	3.30	0.04	1.42	0.39	3.30	2.54	3.73	4.16	6.47	5.72	ns
100 µA	8 mA	Std.	0.63	3.87	0.05	1.67	0.45	3.87	2.98	4.38	4.89	7.61	6.72	ns
		–1	0.54	3.30	0.04	1.42	0.39	3.30	2.54	3.73	4.16	6.47	5.72	ns
100 µA	12 mA	Std.	0.63	3.46	0.05	1.67	0.45	3.46	2.61	4.74	5.48	7.19	6.35	ns
		–1	0.54	2.94	0.04	1.42	0.3	2.94	2.22	4.03	4.66	6.12	5.40	ns
100 µA	16 mA	Std.	0.63	3.46	0.05	1.67	0.45	3.46	2.61	4.74	5.48	7.19	6.35	ns
		–1	0.54	2.94	0.04	1.42	0.39	2.94	2.22	4.03	4.66	6.12	5.40	ns

Notes:

1. *Note that 3.3 V LVCMOS wide range is applicable to 100 µA drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges only.*
2. *For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.*

Table 2-80 • 2.5 V LVCMOS Low Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V
Applicable to Standard Plus I/O Banks

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
4 mA	Std.	0.63	6.45	0.05	1.43	0.45	6.56	5.71	2.48	2.19	9.02	8.17	ns
	–1	0.54	5.48	0.04	1.21	0.39	5.58	4.86	2.11	1.86	7.68	6.95	ns
6 mA	Std.	0.63	5.28	0.05	1.43	0.45	5.38	4.92	2.85	2.88	7.84	7.38	ns
	–1	0.54	4.50	0.04	1.21	0.39	4.58	4.19	2.42	2.45	6.67	6.28	ns
8 mA	Std.	0.63	5.28	0.05	1.43	0.45	5.38	4.92	2.85	2.88	7.84	7.38	ns
	–1	0.54	4.50	0.04	1.21	0.39	4.58	4.19	2.42	2.45	6.67	6.28	ns
12 mA	Std.	0.63	4.48	0.05	1.43	0.45	4.56	4.35	3.11	3.31	7.02	6.81	ns
	–1	0.54	3.81	0.04	1.21	0.39	3.88	3.70	2.65	2.82	5.97	5.79	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

Table 2-81 • 2.5 V LVCMOS High Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V
Applicable to Standard Plus I/O Banks

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
4 mA	Std.	0.63	3.18	0.05	1.43	0.45	3.23	2.92	2.48	2.28	5.69	5.38	ns
	–1	0.54	2.70	0.04	1.21	0.39	2.75	2.48	2.11	1.94	4.84	4.58	ns
6 mA	Std.	0.63	2.57	0.05	1.43	0.45	2.62	2.24	2.84	2.98	5.08	4.70	ns
	–1	0.54	2.19	0.04	1.21	0.39	2.23	1.90	2.42	2.54	4.32	4.00	ns
8 mA	Std.	0.63	2.57	0.05	1.43	0.45	2.62	2.24	2.84	2.98	5.08	4.70	ns
	–1	0.54	2.19	0.04	1.21	0.39	2.23	1.90	2.42	2.54	4.32	4.00	ns
12 mA	Std.	0.63	2.28	0.05	1.43	0.45	2.32	1.90	3.11	3.42	4.78	4.36	ns
	–1	0.54	1.94	0.04	1.21	0.39	1.97	1.62	2.64	2.91	4.07	3.71	ns

Notes:

1. *Software default selection highlighted in gray.*
2. *For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.*

1.5 V DC Core Voltage

Table 2-100 • 1.5 V LVCMOS Low Slew
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V, Worst-Case VCCI = 1.4 V
Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{PYS}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
2 mA	Std.	0.61	9.39	0.04	1.88	2.77	0.40	9.54	7.77	3.22	2.47	11.00	9.24	ns
	–1	0.52	7.99	0.03	1.60	2.35	0.34	8.11	6.61	2.74	2.10	9.36	7.86	ns
4 mA	Std.	0.61	8.01	0.04	1.88	2.77	0.40	8.13	6.77	3.58	3.14	9.59	8.24	ns
	–1	0.52	6.81	0.03	1.60	2.35	0.34	6.91	5.76	3.05	2.67	8.16	7.01	ns
6 mA	Std.	0.61	7.51	0.04	1.88	2.77	0.40	7.62	6.59	3.66	3.32	9.09	8.05	ns
	–1	0.52	6.39	0.03	1.60	2.35	0.34	6.48	5.60	3.12	2.83	7.73	6.85	ns
8 mA	Std.	0.61	7.41	0.04	1.88	2.77	0.40	7.52	6.59	3.41	3.99	8.99	8.06	ns
	–1	0.52	6.30	0.03	1.60	2.35	0.34	6.40	5.61	2.90	3.40	7.64	6.85	ns
12 mA	Std.	0.61	7.41	0.04	1.88	2.77	0.40	7.52	6.59	3.41	3.99	8.99	8.06	ns
	–1	0.52	6.30	0.03	1.60	2.35	0.34	6.40	5.61	2.90	3.40	7.64	6.85	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-101 • 1.5 V LVCMOS High Slew
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V, Worst-Case VCCI = 1.4 V
Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{PYS}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
2 mA	Std.	0.61	3.78	0.04	1.88	2.77	0.40	3.82	3.43	3.21‘	2.58	5.29	4.89	ns
	–1	0.52	3.21	0.03	1.60	2.35	0.34	3.25	2.92	2.73	2.20	4.50	4.16	ns
4 mA	Std.	0.61	3.20	0.04	1.88	2.77	0.40	3.23	2.79	3.57	3.25	4.70	4.25	ns
	–1	0.52	2.72	0.03	1.60	2.35	0.34	2.75	2.37	3.04	2.77	4.00	3.62	ns
6 mA	Std.	0.61	3.09	0.04	1.88	2.77	0.40	3.12	2.67	3.65	3.44	4.59	4.13	ns
	–1	0.52	2.63	0.03	1.60	2.35	0.34	2.65	2.27	3.11	2.93	3.90	3.52	ns
8 mA	Std.	0.61	3.05	0.04	1.88	2.77	0.40	3.09	2.52	3.77	4.14	4.55	3.98	ns
	–1	0.52	2.60	0.03	1.60	2.35	0.34	2.62	2.14	3.21	3.52	3.87	3.39	ns
12 mA	Std.	0.61	3.05	0.04	1.88	2.77	0.40	3.09	2.52	3.77	4.14	4.55	3.98	ns
	–1	0.52	2.60	0.03	1.60	2.35	0.34	2.62	2.14	3.21	3.52	3.87	3.39	ns

Notes:

1. *Software default selection highlighted in gray.*
2. *For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.*

Timing Characteristics

1.2 V DC Core Voltage

Table 2-108 • 1.2 V LVCMOS Low Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V
Applicable to Pro I/O Banks for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{PYS}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
2 mA	Std.	0.80	12.61	0.05	2.65	3.75	0.52	12.10	9.50	5.11	4.66	14.31	11.71	ns
	–1	0.68	10.72	0.05	2.25	3.19	0.44	10.30	8.08	4.35	3.97	12.17	9.96	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-109 • 1.2 V LVCMOS High Slew
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V
Applicable to Pro I/O Banks for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{PYS}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
2 mA	Std.	0.80	5.16	0.05	2.65	3.75	0.52	4.98	4.39	5.10	4.81	7.19	6.60	ns
	–1	0.68	4.39	0.05	2.25	3.19	0.44	4.24	3.74	4.34	4.09	6.11	5.61	ns

Notes:

1. *Software default selection highlighted in gray.*
2. *For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.*

2.5 V GTL

Gunning Transceiver Logic is a high-speed bus standard (JESD8-3). It provides a differential amplifier input buffer and an open-drain output buffer. The V_{CCI} pin should be connected to 2.5 V.

Table 2-124 • Minimum and Maximum DC Input and Output Levels

2.5 V GTL	VIL		VIH		VOL	VOH	I_{OL}	I_{OH}	I_{OSL}	I_{OSH}	I_{IL}[1]	I_{IH}[2]
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA[3]	Max. mA[3]	µA[4]	µA[4]
20 mA[5]	–0.3	VREF – 0.05	VREF + 0.05	3.6	0.4	–	20	20	169	124	15	15

Notes:

1. *I_{IL} is the input leakage current per I/O pin over recommended operating conditions where –0.3 V < VIN < VIL.*
2. *I_{IH} is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.*
3. *Currents are measured at 100°C junction temperature and maximum voltage.*
4. *Currents are measured at 125°C junction temperature.*
5. *Output drive strength is below JEDEC specification.*

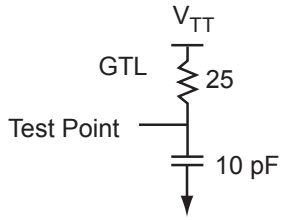

Figure 2-16 • AC Loading

Table 2-125 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	VREF (typ.) (V)	V_{TT} (typ.) (V)	C_{LOAD} (pF)
VREF – 0.05	VREF + 0.05	0.8	0.8	1.2	10

*Note: *Measuring point = V_{trip}. See Table 2-29 on page 2-25 for a complete table of trip points.*

Timing Characteristics

Table 2-126 • 2.5 V GTL
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.14 V,
Worst-Case VCCI = 3.0 V, VREF = 0.8 V
Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
Std.	0.80	2.11	0.05	2.26	0.52	2.14	2.11	–	–	4.34	4.31	ns
–1	0.68	1.79	0.05	1.93	0.44	1.82	1.79	–	–	3.70	3.68	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-127 • 2.5 V GTL
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V,
Worst-Case VCCI = 3.0 V, VREF = 0.8 V
Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	t_{DOUT}	t_{DP}	t_{DIN}	t_{PY}	t_{EOUT}	t_{ZL}	t_{ZH}	t_{LZ}	t_{HZ}	t_{ZLS}	t_{ZHS}	Units
Std.	0.61	2.02	0.04	2.04	0.40	1.98	2.02	–	–	3.45	3.49	ns
–1	0.52	1.72	0.03	1.73	0.34	1.69	1.72	–	–	2.93	2.97	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Input Register

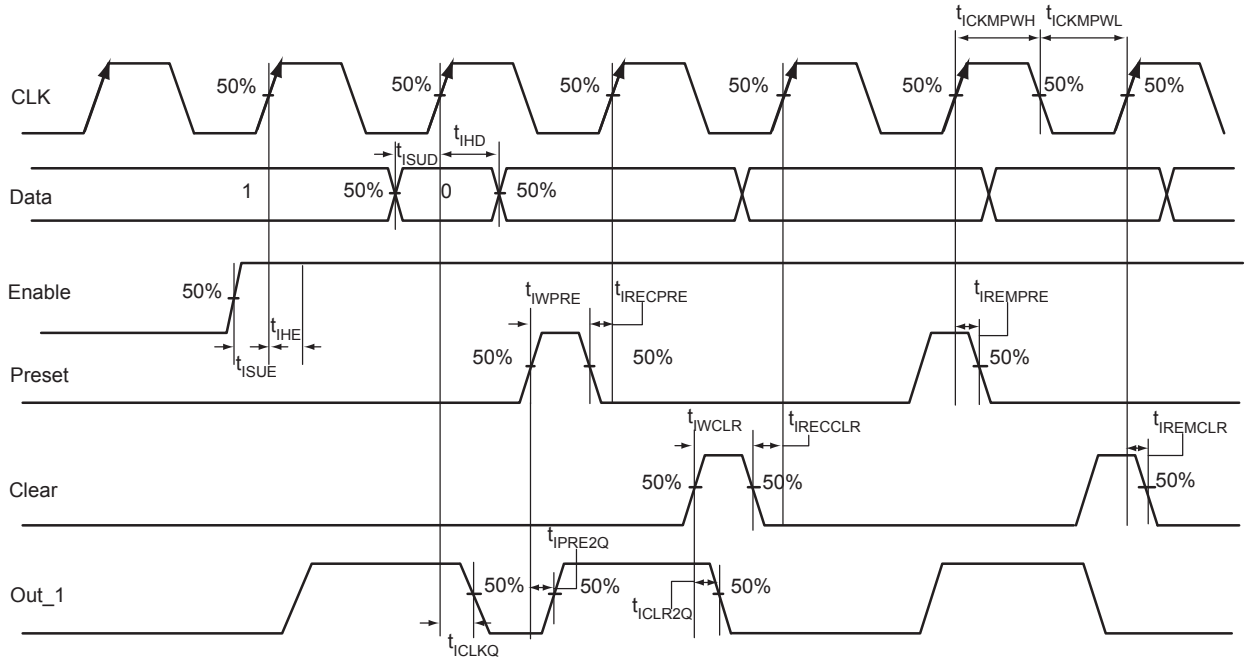

Figure 2-30 • **Input Register Timing Diagram**

Timing Characteristics

Table 2-172 • Input Data Register Propagation Delays
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.14 V for A3PE600L and A3PE3000L

Parameter	Description	–1	Std.	Units
t_{ICLKQ}	Clock-to-Q of the Input Data Register	0.33	0.39	ns
t_{ISUD}	Data Setup Time for the Input Data Register	0.36	0.43	ns
t_{IHD}	Data Hold Time for the Input Data Register	0.00	0.00	ns
t_{ISUE}	Enable Setup Time for the Input Data Register	0.51	0.60	ns
t_{IHE}	Enable Hold Time for the Input Data Register	0.00	0.00	ns
t_{ICLR2Q}	Asynchronous Clear-to-Q of the Input Data Register	0.63	0.74	ns
t_{IPRE2Q}	Asynchronous Preset-to-Q of the Input Data Register	0.63	0.74	ns
$t_{IREMCLR}$	Asynchronous Clear Removal Time for the Input Data Register	0.00	0.00	ns
$t_{IRECCLR}$	Asynchronous Clear Recovery Time for the Input Data Register	0.31	0.36	ns
$t_{IREMPRE}$	Asynchronous Preset Removal Time for the Input Data Register	0.00	0.00	ns
$t_{IRECPRE}$	Asynchronous Preset Recovery Time for the Input Data Register	0.31	0.36	ns
t_{IWCLR}	Asynchronous Clear Minimum Pulse Width for the Input Data Register	0.19	0.22	ns
t_{IWPRE}	Asynchronous Preset Minimum Pulse Width for the Input Data Register	0.19	0.22	ns
$t_{ICKMPWH}$	Clock Minimum Pulse Width HIGH for the Input Data Register	0.31	0.36	ns
$t_{ICKMPWL}$	Clock Minimum Pulse Width LOW for the Input Data Register	0.28	0.32	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-173 • Input Data Register Propagation Delays
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V for A3PE600L and A3PE3000L

Parameter	Description	–1	Std.	Units
t_{ICLKQ}	Clock-to-Q of the Input Data Register	0.25	0.30	ns
t_{ISUD}	Data Setup Time for the Input Data Register	0.28	0.33	ns
t_{IHD}	Data Hold Time for the Input Data Register	0.00	0.00	ns
t_{ISUE}	Enable Setup Time for the Input Data Register	0.39	0.46	ns
t_{IHE}	Enable Hold Time for the Input Data Register	0.00	0.00	ns
t_{ICLR2Q}	Asynchronous Clear-to-Q of the Input Data Register	0.48	0.56	ns
t_{IPRE2Q}	Asynchronous Preset-to-Q of the Input Data Register	0.48	0.56	ns
$t_{IREMCLR}$	Asynchronous Clear Removal Time for the Input Data Register	0.00	0.00	ns
$t_{IRECCLR}$	Asynchronous Clear Recovery Time for the Input Data Register	0.24	0.28	ns
$t_{IREMPRE}$	Asynchronous Preset Removal Time for the Input Data Register	0.00	0.00	ns
$t_{IRECPRE}$	Asynchronous Preset Recovery Time for the Input Data Register	0.24	0.28	ns
t_{IWCLR}	Asynchronous Clear Minimum Pulse Width for the Input Data Register	0.19	0.22	ns
t_{IWPRE}	Asynchronous Preset Minimum Pulse Width for the Input Data Register	0.19	0.22	ns
$t_{ICKMPWH}$	Clock Minimum Pulse Width HIGH for the Input Data Register	0.31	0.36	ns
$t_{ICKMPWL}$	Clock Minimum Pulse Width LOW for the Input Data Register	0.28	0.32	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Timing Characteristics

Table 2-175 • Output Data Register Propagation Delays
Military-Case Conditions: T_J = 125°C, Worst-Case VCC = 1.14 V for A3PE600L and A3PE3000L

Parameter	Description	–1	Std.	Units
t_{OCLKQ}	Clock-to-Q of the Output Data Register	0.81	0.96	ns
t_{OSUD}	Data Setup Time for the Output Data Register	0.43	0.51	ns
t_{OHD}	Data Hold Time for the Output Data Register	0.00	0.00	ns
t_{OSUE}	Enable Setup Time for the Output Data Register	0.61	0.71	ns
t_{OHE}	Enable Hold Time for the Output Data Register	0.00	0.00	ns
t_{OCLR2Q}	Asynchronous Clear-to-Q of the Output Data Register	1.11	1.31	ns
t_{OPRE2Q}	Asynchronous Preset-to-Q of the Output Data Register	1.11	1.31	ns
$t_{OREMCLR}$	Asynchronous Clear Removal Time for the Output Data Register	0.00	0.00	ns
$t_{ORECCLR}$	Asynchronous Clear Recovery Time for the Output Data Register	0.31	0.36	ns
$t_{OREMPRE}$	Asynchronous Preset Removal Time for the Output Data Register	0.00	0.00	ns
$t_{ORECPRE}$	Asynchronous Preset Recovery Time for the Output Data Register	0.31	0.36	ns
t_{OWCLR}	Asynchronous Clear Minimum Pulse Width for the Output Data Register	0.19	0.22	ns
t_{OWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Data Register	0.19	0.22	ns
$t_{OCKMPWH}$	Clock Minimum Pulse Width HIGH for the Output Data Register	0.31	0.36	ns
$t_{OCKMPWL}$	Clock Minimum Pulse Width LOW for the Output Data Register	0.28	0.32	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-176 • Output Data Register Propagation Delays
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V for A3PE600L and A3PE3000L

Parameter	Description	–1	Std.	Units
t_{OCLKQ}	Clock-to-Q of the Output Data Register	0.62	0.73	ns
t_{OSUD}	Data Setup Time for the Output Data Register	0.33	0.39	ns
t_{OHD}	Data Hold Time for the Output Data Register	0.00	0.00	ns
t_{OSUE}	Enable Setup Time for the Output Data Register	0.46	0.55	ns
t_{OHE}	Enable Hold Time for the Output Data Register	0.00	0.00	ns
t_{OCLR2Q}	Asynchronous Clear-to-Q of the Output Data Register	0.85	1.00	ns
t_{OPRE2Q}	Asynchronous Preset-to-Q of the Output Data Register	0.85	1.00	ns
$t_{OREMCLR}$	Asynchronous Clear Removal Time for the Output Data Register	0.00	0.00	ns
$t_{ORECCLR}$	Asynchronous Clear Recovery Time for the Output Data Register	0.24	0.28	ns
$t_{OREMPRE}$	Asynchronous Preset Removal Time for the Output Data Register	0.00	0.00	ns
$t_{ORECPRE}$	Asynchronous Preset Recovery Time for the Output Data Register	0.24	0.28	ns
t_{OWCLR}	Asynchronous Clear Minimum Pulse Width for the Output Data Register	0.19	0.22	ns
t_{OWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Data Register	0.19	0.22	ns
$t_{OCKMPWH}$	Clock Minimum Pulse Width HIGH for the Output Data Register	0.31	0.36	ns
$t_{OCKMPWL}$	Clock Minimum Pulse Width LOW for the Output Data Register	0.28	0.32	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-199 • A3P250 Global Resource
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V

Parameter	Description	–1		Std.		Units
		Min.[1]	Max.[2]	Min.[1]	Max.[2]	
t_{RCKL}	Input Low Delay for Global Clock	0.97	1.24	1.14	1.46	ns
t_{RCKH}	Input High Delay for Global Clock	0.94	1.27	1.11	1.49	ns
$t_{RCKMPWH}$	Minimum Pulse Width High for Global Clock					ns
$t_{RCKMPWL}$	Minimum Pulse Width Low for Global Clock					ns
t_{RCKSW}	Maximum Skew for Global Clock		0.32		0.38	ns
F_{RMAX}	Maximum Frequency for Global Clock					MHz

Notes:

1. *Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).*
2. *Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).*
3. *For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.*

Table 2-200 • A3P1000 Global Resource
Military-Case Conditions: T_J = 125°C, VCC = 1.425 V

Parameter	Description	–1		Std.		Units
		Min.[1]	Max.[2]	Min.[1]	Max.[2]	
t_{RCKL}	Input Low Delay for Global Clock	1.18	1.44	1.39	1.70	ns
t_{RCKH}	Input High Delay for Global Clock	1.17	1.48	1.37	1.74	ns
$t_{RCKMPWH}$	Minimum Pulse Width High for Global Clock					ns
$t_{RCKMPWL}$	Minimum Pulse Width Low for Global Clock					ns
t_{RCKSW}	Maximum Skew for Global Clock		0.32		0.37	ns
F_{RMAX}	Maximum Frequency for Global Clock					MHz

Notes:

1. *Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).*
2. *Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).*
3. *For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.*

FG144	
Pin Number	**A3P1000 Function**
K1	GEB0/IO189NDB3
K2	GEA1/IO188PDB3
K3	GEA0/IO188NDB3
K4	GEA2/IO187RSB2
K5	IO169RSB2
K6	IO152RSB2
K7	GND
K8	IO117RSB2
K9	GDC2/IO116RSB2
K10	GND
K11	GDA0/IO113NDB1
K12	GDB0/IO112NDB1
L1	GND
L2	VMV3
L3	GEB2/IO186RSB2
L4	IO172RSB2
L5	VCCIB2
L6	IO153RSB2
L7	IO144RSB2
L8	IO140RSB2
L9	TMS
L10	VJTAG
L11	VMV2
L12	TRST
M1	GNDQ
M2	GEC2/IO185RSB2
M3	IO173RSB2
M4	IO168RSB2
M5	IO161RSB2
M6	IO156RSB2
M7	IO145RSB2
M8	IO141RSB2
M9	TDI
M10	VCCIB2
M11	VPUMP
M12	GNDQ

FG484	
Pin Number	A3PE600L Function
K13	GND
K14	VCC
K15	VCCIB2
K16	GCC1/IO50PPB2V1
K17	IO44NDB2V1
K18	IO44PDB2V1
K19	IO49NPB2V1
K20	IO45NDB2V1
K21	IO48NDB2V1
K22	IO46NDB2V1
L1	NC
L2	IO122PDB7V0
L3	IO122NDB7V0
L4	GFB0/IO119NPB7V0
L5	GFA0/IO118NDB6V1
L6	GFB1/IO119PPB7V0
L7	VCOMPLF
L8	GFC0/IO120NPB7V0
L9	VCC
L10	GND
L11	GND
L12	GND
L13	GND
L14	VCC
L15	GCC0/IO50NPB2V1
L16	GCB1/IO51PPB2V1
L17	GCA0/IO52NPB3V0
L18	VCOMPLC
L19	GCB0/IO51NPB2V1
L20	IO49PPB2V1
L21	IO47NDB2V1
L22	IO47PDB2V1
M1	NC
M2	IO114NDB6V1
M3	IO117NDB6V1

FG484	
Pin Number	A3PE600L Function
M4	GFA2/IO117PDB6V1
M5	GFA1/IO118PDB6V1
M6	VCCPLF
M7	IO116NDB6V1
M8	GFB2/IO116PDB6V1
M9	VCC
M10	GND
M11	GND
M12	GND
M13	GND
M14	VCC
M15	GCB2/IO54PPB3V0
M16	GCA1/IO52PPB3V0
M17	GCC2/IO55PPB3V0
M18	VCCPLC
M19	GCA2/IO53PDB3V0
M20	IO53NDB3V0
M21	IO56PDB3V0
M22	NC
N1	IO114PDB6V1
N2	IO111NDB6V1
N3	NC
N4	GFC2/IO115PDB6V1
N5	IO113PPB6V1
N6	IO112PDB6V1
N7	IO112NDB6V1
N8	VCCIB6
N9	VCC
N10	GND
N11	GND
N12	GND
N13	GND
N14	VCC
N15	VCCIB3
N16	IO54NPB3V0

FG484	
Pin Number	A3PE600L Function
N17	IO57NPB3V0
N18	IO55NPB3V0
N19	IO57PPB3V0
N20	NC
N21	IO56NDB3V0
N22	IO58PDB3V0
P1	NC
P2	IO111PDB6V1
P3	IO115NDB6V1
P4	IO113NPB6V1
P5	IO109PPB6V0
P6	IO108PDB6V0
P7	IO108NDB6V0
P8	VCCIB6
P9	GND
P10	VCC
P11	VCC
P12	VCC
P13	VCC
P14	GND
P15	VCCIB3
P16	GDB0/IO66NPB3V1
P17	IO60NDB3V1
P18	IO60PDB3V1
P19	IO61PDB3V1
P20	NC
P21	IO59PDB3V0
P22	IO58NDB3V0
R1	NC
R2	IO110PDB6V0
R3	VCC
R4	IO109NPB6V0
R5	IO106NDB6V0
R6	IO106PDB6V0
R7	GEC0/IO104NPB6V0

FG484	
Pin Number	A3P1000 Function
A1	GND
A2	GND
A3	VCCIB0
A4	IO07RSB0
A5	IO09RSB0
A6	IO13RSB0
A7	IO18RSB0
A8	IO20RSB0
A9	IO26RSB0
A10	IO32RSB0
A11	IO40RSB0
A12	IO41RSB0
A13	IO53RSB0
A14	IO59RSB0
A15	IO64RSB0
A16	IO65RSB0
A17	IO67RSB0
A18	IO69RSB0
A19	NC
A20	VCCIB0
A21	GND
A22	GND
B1	GND
B2	VCCIB3
B3	NC
B4	IO06RSB0
B5	IO08RSB0
B6	IO12RSB0
B7	IO15RSB0
B8	IO19RSB0
B9	IO24RSB0
B10	IO31RSB0
B11	IO39RSB0
B12	IO48RSB0
B13	IO54RSB0

FG484	
Pin Number	A3P1000 Function
B14	IO58RSB0
B15	IO63RSB0
B16	IO66RSB0
B17	IO68RSB0
B18	IO70RSB0
B19	NC
B20	NC
B21	VCCIB1
B22	GND
C1	VCCIB3
C2	IO220PDB3
C3	NC
C4	NC
C5	GND
C6	IO10RSB0
C7	IO14RSB0
C8	VCC
C9	VCC
C10	IO30RSB0
C11	IO37RSB0
C12	IO43RSB0
C13	NC
C14	VCC
C15	VCC
C16	NC
C17	NC
C18	GND
C19	NC
C20	NC
C21	NC
C22	VCCIB1
D1	IO219PDB3
D2	IO220NDB3
D3	NC
D4	GND

FG484	
Pin Number	A3P1000 Function
D5	GAA0/IO00RSB0
D6	GAA1/IO01RSB0
D7	GAB0/IO02RSB0
D8	IO16RSB0
D9	IO22RSB0
D10	IO28RSB0
D11	IO35RSB0
D12	IO45RSB0
D13	IO50RSB0
D14	IO55RSB0
D15	IO61RSB0
D16	GBB1/IO75RSB0
D17	GBA0/IO76RSB0
D18	GBA1/IO77RSB0
D19	GND
D20	NC
D21	NC
D22	NC
E1	IO219NDB3
E2	NC
E3	GND
E4	GAB2/IO224PDB3
E5	GAA2/IO225PDB3
E6	GNDQ
E7	GAB1/IO03RSB0
E8	IO17RSB0
E9	IO21RSB0
E10	IO27RSB0
E11	IO34RSB0
E12	IO44RSB0
E13	IO51RSB0
E14	IO57RSB0
E15	GBC1/IO73RSB0
E16	GBB0/IO74RSB0
E17	IO71RSB0

FG484	
Pin Number	A3P1000 Function
R8	VMV3
R9	VCCIB2
R10	VCCIB2
R11	IO147RSB2
R12	IO136RSB2
R13	VCCIB2
R14	VCCIB2
R15	VMV2
R16	IO110NDB1
R17	GDB1/IO112PPB1
R18	GDC1/IO111PDB1
R19	IO107NDB1
R20	VCC
R21	IO104NDB1
R22	IO105PDB1
T1	IO198PDB3
T2	IO198NDB3
T3	NC
T4	IO194PPB3
T5	IO192PPB3
T6	GEC1/IO190PPB3
T7	IO192NPB3
T8	GNDQ
T9	GEA2/IO187RSB2
T10	IO161RSB2
T11	IO155RSB2
T12	IO141RSB2
T13	IO129RSB2
T14	IO124RSB2
T15	GNDQ
T16	IO110PDB1
T17	VJTAG
T18	GDC0/IO111NDB1
T19	GDA1/IO113PDB1
T20	NC

FG484	
Pin Number	A3P1000 Function
T21	IO108PDB1
T22	IO105NDB1
U1	IO195PDB3
U2	IO195NDB3
U3	IO194NPB3
U4	GEB1/IO189PDB3
U5	GEB0/IO189NDB3
U6	VMV2
U7	IO179RSB2
U8	IO171RSB2
U9	IO165RSB2
U10	IO159RSB2
U11	IO151RSB2
U12	IO137RSB2
U13	IO134RSB2
U14	IO128RSB2
U15	VMV1
U16	TCK
U17	VPUMP
U18	TRST
U19	GDA0/IO113NDB1
U20	NC
U21	IO108NDB1
U22	IO109PDB1
V1	NC
V2	NC
V3	GND
V4	GEA1/IO188PDB3
V5	GEA0/IO188NDB3
V6	IO184RSB2
V7	GEC2/IO185RSB2
V8	IO168RSB2
V9	IO163RSB2
V10	IO157RSB2
V11	IO149RSB2

FG484	
Pin Number	A3P1000 Function
V12	IO143RSB2
V13	IO138RSB2
V14	IO131RSB2
V15	IO125RSB2
V16	GDB2/IO115RSB2
V17	TDI
V18	GNDQ
V19	TDO
V20	GND
V21	NC
V22	IO109NDB1
W1	NC
W2	IO191PDB3
W3	NC
W4	GND
W5	IO183RSB2
W6	GEB2/IO186RSB2
W7	IO172RSB2
W8	IO170RSB2
W9	IO164RSB2
W10	IO158RSB2
W11	IO153RSB2
W12	IO142RSB2
W13	IO135RSB2
W14	IO130RSB2
W15	GDC2/IO116RSB2
W16	IO120RSB2
W17	GDA2/IO114RSB2
W18	TMS
W19	GND
W20	NC
W21	NC
W22	NC
Y1	VCCIB3
Y2	IO191NDB3

FG896	
Pin Number	**A3PE3000L Function**
M14	GND
M15	GND
M16	GND
M17	GND
M18	GND
M19	GND
M20	VCC
M21	VCCIB2
M22	NC
M23	IO104PPB2V2
M24	IO102PDB2V2
M25	IO102NDB2V2
M26	IO95PDB2V1
M27	IO97NDB2V1
M28	IO101NDB2V2
M29	IO103NDB2V2
M30	IO119PDB3V0
N1	IO276PDB7V0
N2	IO278PDB7V0
N3	IO280PDB7V0
N4	IO284PDB7V1
N5	IO279PDB7V0
N6	IO285NDB7V1
N7	IO287NDB7V1
N8	IO281NDB7V0
N9	IO281PDB7V0
N10	VCCIB7
N11	VCC
N12	GND
N13	GND
N14	GND
N15	GND
N16	GND
N17	GND
N18	GND
N19	GND